

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination BERMAN ET AL.	
			Examiner Saeed T. Chaudhry	Art Unit 1746	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,138,698	10-2000	Tanaka et al.	134/184
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	JP11008214	01-1999	JAPAN	SAITO et al	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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